# **Dielectric relaxation in polych Iorotrifluoroethylene**

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The effect of increasing lamellar thickness in bulk polychlorotrifluoroethylene (PCTFE) by various methods (annealing and increasing time and temperature of crystallisation) on the parameters of the  $\alpha$  and  $\gamma$  relaxations has been studied.

For the  $\alpha$  relaxation a consistent increase in temperature of maximum loss and activation energy with increasing lamellar thickness confirms the strong suggestion of earlier work [6] on oriented specimens and shows that the  $\alpha$  relaxation arises mainly in the interior of the lamellae with little contribution from the chain folds.

No systematic changes in these parameters with increasing lamellar thickness was found for the  $\gamma$  relaxation and this is explained by the presence of  $\gamma_c$  and  $\gamma_a$  components in crystalline and amorphous regions respectively. The component  $\gamma_a$  (as well as the  $y_c$  one) shows a marked anisotropy in magnitude with respect to the draw direction in oriented specimens relative to the direction of the applied electric field. This implies a "lining up" of the chain molecules parallel to one another in amorphous regions.

The non-existence of analogous short chain compounds and experimental scatter prevented detailed checking of the consistency of the data for the  $\alpha$  relaxation with the theory for the  $\alpha_e - C_e$  model [5].

#### **1. Introduction**

Previous work on polychlorotrifluoroethylene (PCTFE) has revealed 3 main relaxations [1-5]. These consist of the  $\alpha$ ,  $\beta$  and  $\gamma$  processes arising in descending order of temperature (at a given frequency). The  $\alpha$  relaxation has been shown to be associated with crystalline regions, the  $\beta$  with disordered regions and the  $\gamma$  arising from crystalline ( $\gamma$ <sub>e</sub>), and amorphous ( $\gamma$ <sub>a</sub>) regions. However, the exact nature of the  $\alpha$  relaxation has been in doubt. It was considered to arise partly [5] or largely [1] in the fold surfaces of chain folded lamellae and not entirely in their interior.

Preliminary measurements of ours with oriented specimens [6] showed a marked anisotropy with the  $\alpha$  relaxation, strongly suggesting that the  $\alpha$  relaxation arises mainly in the interior of the chain folded lamellae (in specimens of  $80\%$  crystallinity) with little contribution from chain folds. Recent work [7, 8] on single crystals suggests that the folds in bulk polymer specimens may be fairly loose and with lamellae of about 500 A thick in PCTFE, the folds may then contain an appreciable number of carbon atoms, Even though there might be a slight preferred *9 1974 Chapman and Hall Ltd.* 

orientation in the folds, we would expect virtually normal segmented motion, so that even in the oriented specimens the distribution of dipole rotation axes will probably be reasonably random. This should then give little or no anisotropy to the  $\alpha$  relaxation. Moreover, such motion is more likely to be involved in the  $\beta$  relaxation than the  $\alpha$ . Even if the folds are relatively "tight", the most likely motion of the folds is "waggling" out of their plane and assuming one central and two side equilibrium positions, then a movement from the central position to either of the two side positions involves changes in dipole moment along the c-axes of the lamellae and along random directions in the planes at right angles to the c-axes. Although the equivalent changes along three axes at right angles may not be exactly equal, it seems likely that any anisotropy observed would be small, in contrast to the experimental findings. However, it is impossible to be precise, but experimental data described in this paper will show the increase of the activation energy  $\Delta H$ and temperature of maximum loss  $T_{\text{max}}$  (at a given frequency) for the dielectric  $\alpha$  relaxation

with increasing lamellar thickness, as obtained by annealing, by crystallization at increasingly higher temperatures and by crystallization for progressively longer times at a high temperature. These confirm the strong suggestion of the orientation work and show that the  $\alpha$  relaxation arises mainly in the interior of the lamellae (e.g. as in Fig. 1) with little contribution from the



*Figure 1* Model for process  $\alpha_e - C$  (slightly rough fold surface and independent interior chain and fold motions). From Hoffman *et al.* [5].

chain folds, since relaxation arising from chain fold motion ( $\alpha_e$  –  $C_f$  model) should yield  $\Delta H$ and  $T_{\text{max}}$  values independent of lamellar thickness [5].

# **2. Experimental and discussion**

The polymer used was Kel F 81, Grade 3, KF 6060, of purity 99.9% and with a number average molecular weight  $\overline{M}$ n of approx. 190 000 supplied by Minnesota Mining and Manufacturing Co Ltd. Except when otherwise stated, unoriented disc specimens approximately 51 mm in diameter by 1.5 mm thick were used. Thermal treatment of the disc specimen was carried out whilst immersed in silicone oil in small trays in an air oven. Each specimen was cleaned with carbon tetrachloride and the electrodes were applied and measurements made with a G.R. 1615A Capacitance bridge as described previously [6].

## 2.1.  $\alpha$  relaxation

## *2.1.1. Effect of annealing*

The PCTFE specimens were crystallised at  $170^{\circ}$ C for one week after cooling from the melt and subsequently annealed at  $200^{\circ}$ C for various times up to  $10<sup>5</sup>$  min. The actual crystallinity of the samples ranged between 70 and  $80\%$  as evaluated by density measurements [8a]. Typical data shown in Fig. 2 indicate a small but definite increase in  $T_{\text{max}}$  with annealing time. (Average rate of change  $7 \times 10^{-5}$ °C min<sup>-1</sup>.) Correspondingly, plots of loss factor against log frquency at an approximately constant test temperature show that the frequency of maxi mum loss  $f_m$  decreases with increasing annealing time.



*Figure 2* Loss factor (at 10 kHz) versus temperature (~ for specimens annealed at 200~ for different times (after crystallization at 170 $^{\circ}$ C for one week). ( $\circ$ ) no annealing; (+)  $10^3$  min; (\*)  $10^{3.7}$  min; (×)  $10^5$  min. Crystallinity 70 to  $80\%$ .

# *2.1.2. Effect of temperature of crystallization*

Specimens were crystallized for one week (after cooling from the melt) at various temperatures ranging from  $160$  to  $200^{\circ}$ C. The results are shown in Fig. 3. The temperature of maximum loss increases quite significantly with rising crystallization temperature and hence with increasing lamellar thickness. The crystallinity of the specimens ranged between 66 and  $80\%$ . Plots of loss factor against log frequency for the different specimens at a given test temperature showed a corresponding decrease of frequency of maximum loss  $f_m$  with increasing crystallization temperature.

# *2.1.3. Effect of time of crystallization*

Samples were crystallized for different times at



*Figure 3* Loss factor (at 10 kHz) versus temperature (~ for specimens crystallized for one week at different temperatures. ( $\bigcirc$ ) Isothermally crystallized at 160°C; (+) isothermally crystallized at 190 $^{\circ}$ C; (\*) isothermally crystallized at 200 $^{\circ}$ C. Crystallinity 66 to 80 $\%$ .

 $200^{\circ}$ C after cooling from the melt and typical data are shown in Fig. 4. The crystallinity of the specimens ranged between 55 and 80%. The results show a definite increase in  $T_{\text{max}}$  with rising time of crystallization (note that the peak for 1700 min specimen, with a crystallinity of 55%, is largely a  $\beta$  peak). Correspondingly, plots of loss factor against log frequency at an approximately constant test temperature for the different specimens showed a definite fall in frequency of maximum loss  $f_m$  with increasing crystallization time.



*Figure 4* Loss factor (at 10 kHz) versus temperature ( $^{\circ}$ C) for specimens crystallized for different times at  $200^{\circ}$ C. ( $\circ$ ) Crystallized for 1700 min; (+) crystallized for 2850 min; (\*) crystallized for 5250 min; ( $\times$ ) crystallized for 8500 min. Crystallinity 55 to 80%.

## *2.1.4. Loci plots*

Plots of log frequency of maximum loss  $f_m$ against  $1000/T$  (T being the temperature on the



*Figure 5* (a) Plots of  $log_{10} (f_m)$  versus  $1000/T(K)$  for the  $\alpha$  relaxation in specimens annealed for different times: ( $\odot$ ) 0 min; (\*) 10<sup>4</sup> min; ( $\times$ ) 10<sup>5</sup> min. (b) Plots of log <sub>10</sub> ( $f<sub>m</sub>$ ) versus  $1000/T(K)$  for the  $\alpha$  relaxation in specimens crystallized at different temperatures; ( $\bigcirc$ ) 170°C; ( $\bigtriangleup$ )  $180^{\circ}$ C; (+)  $190^{\circ}$ C.

Kelvin scale) are shown in Fig. 5, for the first two methods of inducing changes in lamellar thickness. The frequency of maximum loss was obtained by interpolation between the experimental data of loss factor versus log frequency (using the computer) and the straight lines drawn through the corresponding points in Fig. 5 were those obtained by the method of least squares fit. The activation energies *AH* were calculated as

$$
- 2.303 R \left[ \frac{\mathrm{dlog}_{10} f_{\mathrm{m}}}{\mathrm{d}(1/T)} \right]
$$

and clearly *AH* increases with increasing annealing time and with rising crystallization temperature. The effect of annealing time is shown in more detail in Fig. 6 which includes data from two different sets of samples. Clearly *AH* increases significantly for the  $\alpha$  relaxation (but there is no change in the activation energy for



*Figure 6* Plots of experimental activation energy  $\Delta H$  versus: log<sub>10</sub> (annealing time in min) for the  $\alpha$  (O) and  $\gamma$  ( $\times$ ). relaxations. Crystallinity 70 to 80 $\%$ .

the  $\gamma$  relaxation. This is discussed in more detail later on).

The data for the different times of crystallization at  $200^{\circ}$ C were not sufficiently well resolved in plots against log frequency to allow a plot of  $\log f_m$  against 1000/T to be drawn.

## *2.1.5. Measurements of lamellar thickness*

Low-angle X-ray measurements were made with a Kratky slit collimated camera and after slit height correction the Bragg equation was applied to the small angle peak and the resulting spacing taken as a measure of the average periodicity [10, 11]. Certain difficulties arise in relating this periodicity to the lamellar thickness and in view of this we have assumed that the low angle spacing  $d$  is a rough measure of lamellar thickness [9]. In Figs. 7 and 8 are shown the variation of temperature of maximum loss  $T_{\text{max}}$  with log d and the variation of *AH* with d.



*Figure* 7 Plots of  $T_{\text{max}}$  for  $\alpha$  relaxation versus log<sub>10</sub> (low-angle spacing  $d$ ) for samples prepared by annealing  $(x)$ , isothermal crystallization  $( \bigcirc )$  and different times of crystallization  $(+)$ ; (\*) oriented highly crystalline (80%) specimen [6].



*Figure 8* Plots of experimental activation energy  $AH$  for  $\alpha$ relaxation versus low angle spacing  $d$  for samples prepared by annealing  $(\times)$ , isothermal crystallization  $(\circ)$ and different times of crystallization  $(+)$ ;  $(*)$  oriented highly crystalline  $(80\%)$  specimen [6].

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In Fig. 7 each method of increasing lamellar thickness gives rise to an increase of  $T<sub>max</sub>$ within the limits of experimental error. Despite some scatter in the data, there is clearly a significant increase in  $T_{\text{max}}$  with log d and a reasonable correlation between the data for the three methods of increasing lamellar thickness. However, the scatter in the data does not allow accurate curve fitting for checking for consistency with the theory for the  $\alpha_e - C_e$  model [5] or for assessing whether chain twisting is occurring. Similarly, in Fig. 8, due to experimental errors and difficulties in assessing slopes of the plots of  $\log f_m$  against 1000/T, the experimental errors in *AH* are appreciable (about  $+10\%$ ). However, the correlation coefficient between the data is 0.78 which is significant at the  $1\%$  level. Thus, despite the scatter in the data, due probably to the comparatively large error in  $\Delta H$ , there is a clear relationship between the variables, *AH*  increasing as spacing  $d$  is made larger.

Thus the gross changes observed in  $T_{\text{max}}$  and *AH* are consistent with the  $\alpha_e - C_e$  model [5] but the scatter in the experimental data precludes any detailed checking. Further measurements on single crystals of PCTFE might yield results with less experimental scatter and which perhaps could be analysed in a more detailed fashion. This work is at present being attempted.

#### 2.2.  $\nu$  relaxation

The loss peaks for the  $\gamma$  relaxation previously shown in Figs. 2 to 4 show little or no systematic changes (apart from a fall in magnitude due to increasing crystallinity) with the varying parameters (i.e. annealing time, or time or temperature of crystallization), and similarly in Fig. 6 the activation energy  $\Delta H$  for the  $\gamma$  relaxation is quite unaffected by annealing time. This behaviour almost certainly arises because the  $\gamma$  relaxation consists of overlapping components from the crystalline ( $\gamma_e$ ) and amorphous ( $\gamma_a$ ) regions. The  $\gamma_a$  component gives a peak at a slightly higher temperature  $(T_{\text{max}})$  at a given frequency than the  $\gamma_0$  one and similarly it has a slightly higher activation energy than the  $\gamma_e$  component. In the various methods used for thickening the lamellae the crystallinity and proportion of  $\gamma_c$ component increases somewhat as the lamellar thickness increases with a probable increase in  $T_{\text{max}}$  and  $\Delta H$  for the  $\gamma$ <sub>e</sub> component but at the same time the proportion of  $\gamma_a$  component (with a higher  $T_{\text{max}}$  and  $\Delta H$  than for the  $\gamma_c$  component) is being reduced. Thus one may expect to see little change in  $T_{\text{max}}$  or  $\Delta H$  for the overall  $\gamma$  relaxation as observed. To check on consistency of the behaviour of  $T_{\text{max}}$  and  $\Delta H$  as the lamellar thickness increases with the predictions of the  $y_c - A$  model [5] measurements will have to be made on single crystals of PCTFE. This work is at present being attempted in our laboratory.

Data presented in previous work [6] clearly showed the anisotropy of (mainly) the  $v_c$ component as would be expected from the  $\gamma_c$  - A model [5]. Measurements made in a similar way on oriented specimens of PCTFE of relatively low crystallinity ( $\approx$  35%) also showed a marked anisotropy (Fig. 9) in what must be mainly the  $\gamma_a$  component. This is consistent with a "lining up" of the molecular chains in amorphous regions with orientation. This is also supported by a definite anisotropy observed with the dielectric  $\beta$  relaxation (Fig. 9).



*Figure 9* Loss factor (at 10 kHz) versus temperature (°C) for isotropic  $( \bigcirc )$  and drawn specimens with draw direction perpendicular  $(+)$  and parallel  $(*)$  to the applied field. Crystallinity approximately  $35\%$ .

## **3. Conclusions**

The increase in temperature of maximum loss  $T_{\text{max}}$  and activation energy  $\Delta H$  for the  $\alpha$ relaxation with increasing lamellar thickness in bulk PCTFE confirm the strong suggestion of earlier work on oriented specimens [6] and show that the  $\alpha$  relaxation arises mainly in the interior

of the lamellae (e.g.  $\alpha_e - C_e$  model [5]) with little contribution from the chain folds. Experimental scatter in the data prevents detailed checking of the consistency of the experimental data with the theory for the  $\alpha_e - C_e$  model.

No systematic changes in the behaviour of  $T_{\text{max}}$  and  $\Delta H$  are found with increasing lamellar thickness for the  $\gamma$  relaxation because of the presence of  $\gamma_c$  and  $\gamma_a$  components. Both  $\gamma_c$  and  $\gamma_a$  components showed a marked anisotropy in magnitude with respect to the orientation direction relative to the applied electric field. For the  $\gamma_a$  component this indicates a "lining up" of the molecular chains parallel to one another in the amorphous regions.

A more detailed check on the theoretical models (e.g.  $\alpha_e - C_e$  and  $\gamma_e - A$ ) [5]) may be possible with data from single crystals of PCTFE which might give less experimental scatter. This work is at present being attempted.

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